Search Notes			
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Application/Control No.	Applicant(s)/Patent under Reexamination
10/770,414	INOUE ET AL.
Examiner	Art Unit
Fetsum Abraham	2826

SEARCHED			
Class	Subclass	Date	Examiner
257	502	3/16/2005	FA
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
257	502	3/16/2005	FA
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